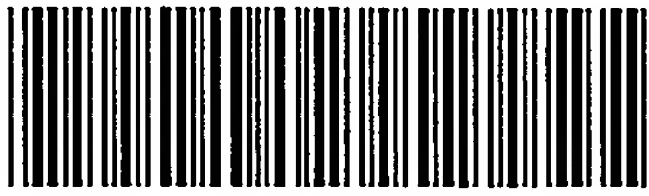


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/621,417	MOTOYAMA, HAJIME	
	Examiner	Art Unit	
	Hai C. Pham	2861	

SEARCHED			
Class	Subclass	Date	Examiner
347	233-235, 248, 250	2/4/2006	HP

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
347	234, 248	2/4/2006	HP
PGPub Text Search		2/4/2006	HP

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST Text Search	2/4/2006	HP